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United States Patent [19]

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Nakajima et al.

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[54] ULTRASONIC FLAW DETECTOR

[56] References Cited

[76] Inventors: **Hiroaki Nakajima**, 16-4, 6-chome, Setagaya-ku, Tokyo; **Kazuhiko Hiraoka**, 16-10, Tateno-cho, Nerima-ku, Tokyo; **Yukio Arima**, 4-24, Inarimae, Tsukuba-shi, Ibaragi-ken; **Hiroaki Yanagimoto**; **Tetsuyoshi Tominaga**, both of 1828, Ohaza Niihari, Chiyoda-mura, Niihari-gun, Ibaragi-ken, all of Japan

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Primary Examiner—Donald P. Walsh
Assistant Examiner—Antoine D. Davis
Attorney, Agent, or Firm—Antonelli, Terry, Stout & Kraus

[**] Term: 14 Years

[57] CLAIM

The ornamental design for an ultrasonic flaw detector, as shown.

[21] Appl. No.: 558,190

DESCRIPTION

[22] Filed: Jul. 26, 1990

FIG. 1 is a perspective view of an ultrasonic flaw detector showing our new design;
FIG. 2 is a front elevational view;
FIG. 3 is a top plan view;
FIG. 4 is a left side elevational view;
FIG. 5 is a right side elevational view;
FIG. 6 is a rear elevational view;
FIG. 7 is a bottom plan view; and,
FIG. 8 is a perspective view thereof, shown with the tray element in an extended condition.

[30] Foreign Application Priority Data

Apr. 27, 1990 [JP] Japan 1-14282
[52] U.S. Cl. D10/75; D10/46
[58] Field of Search D10/46, 75; 73/606, 73/607, 621, 629, 618, 649, 658, 659, 660

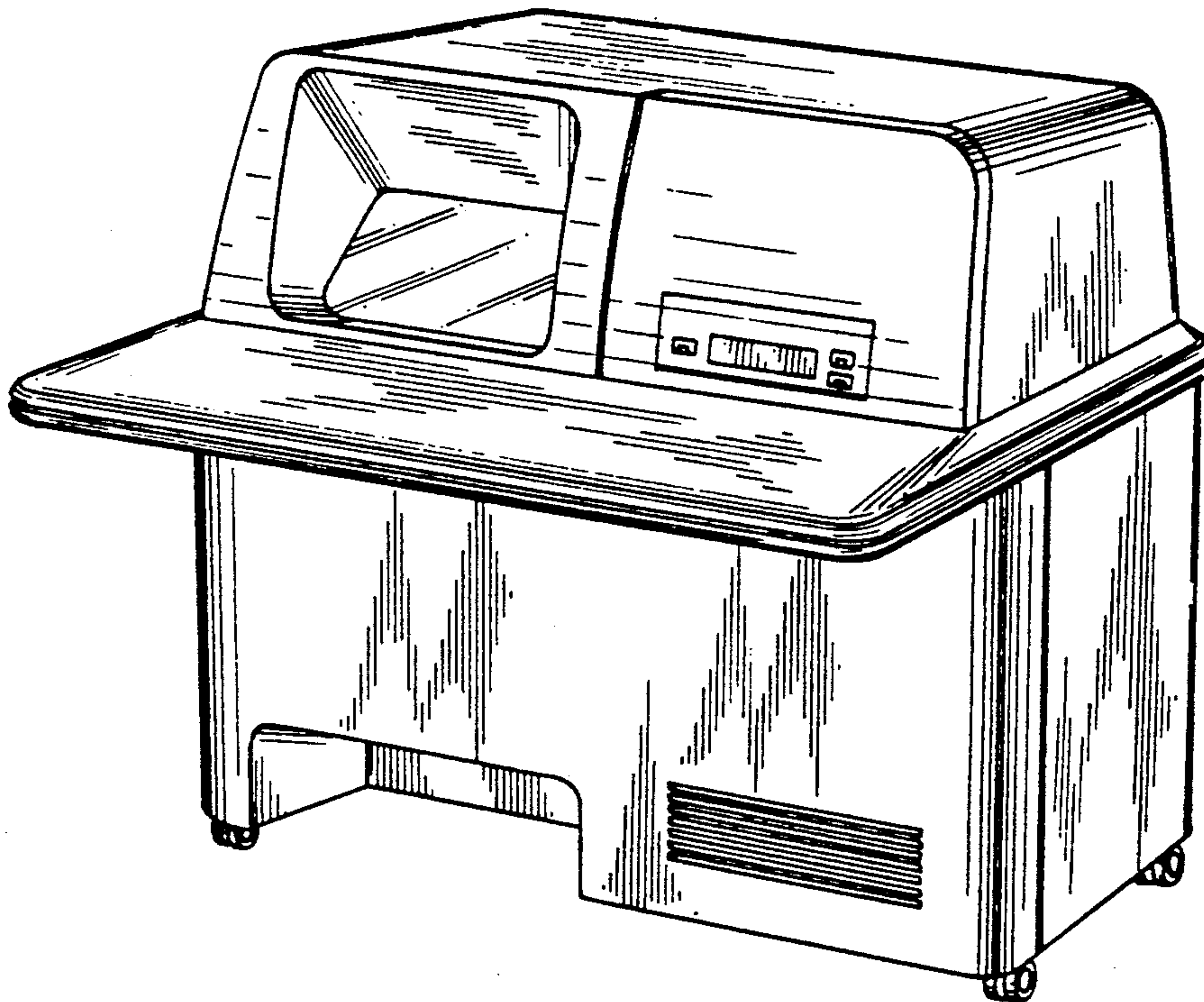


FIG. 1

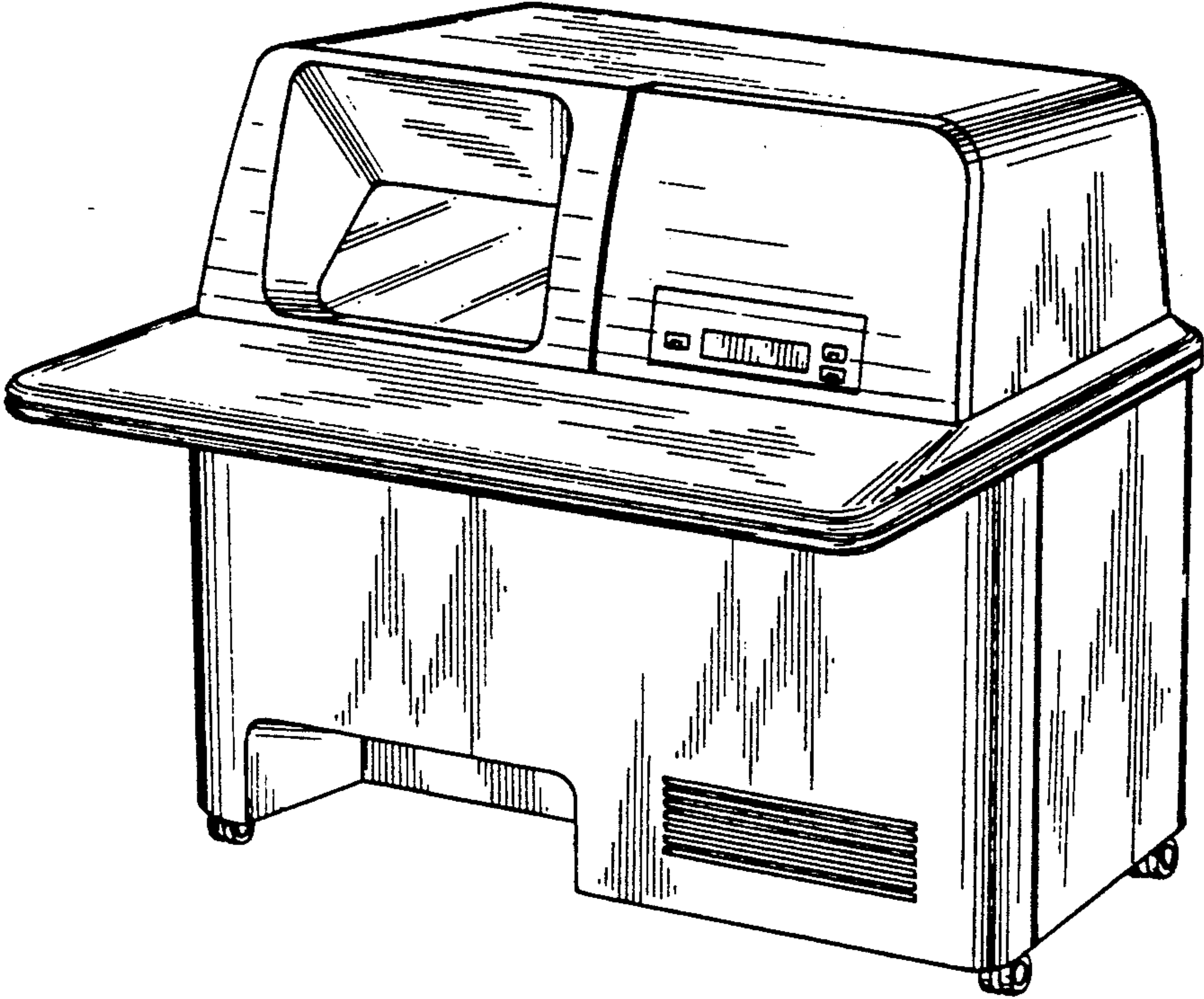


FIG. 2

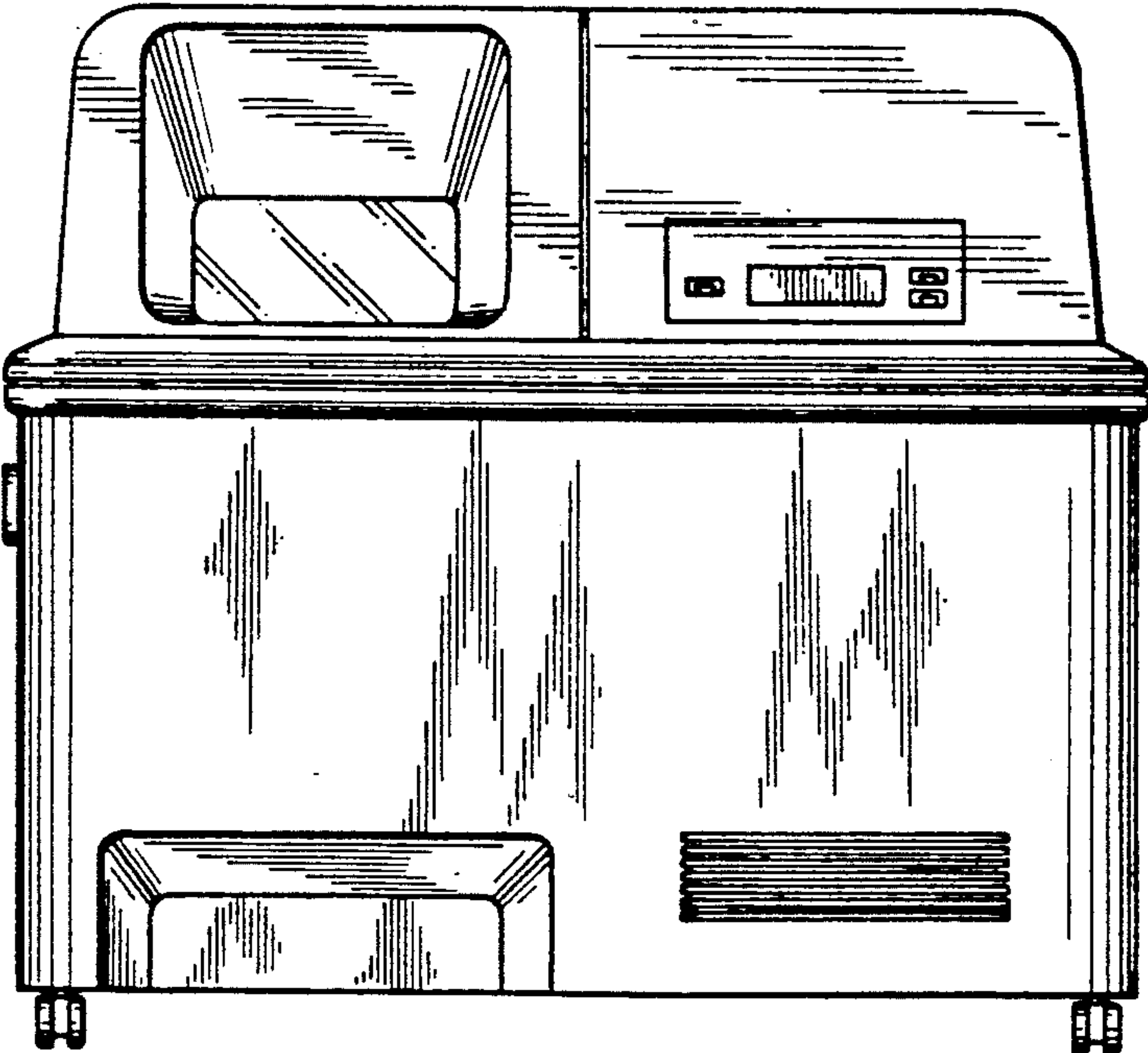


FIG. 3

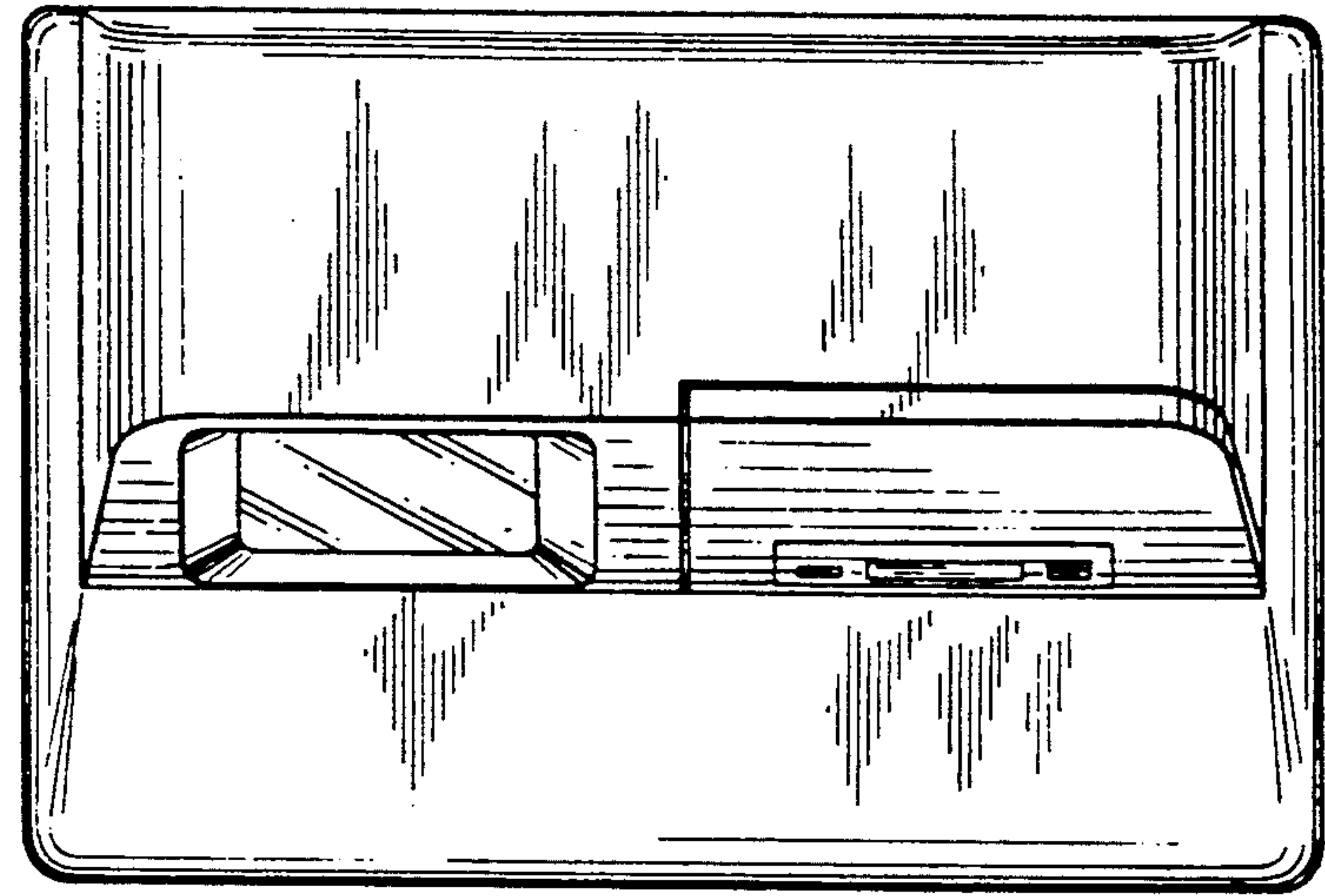


FIG. 4

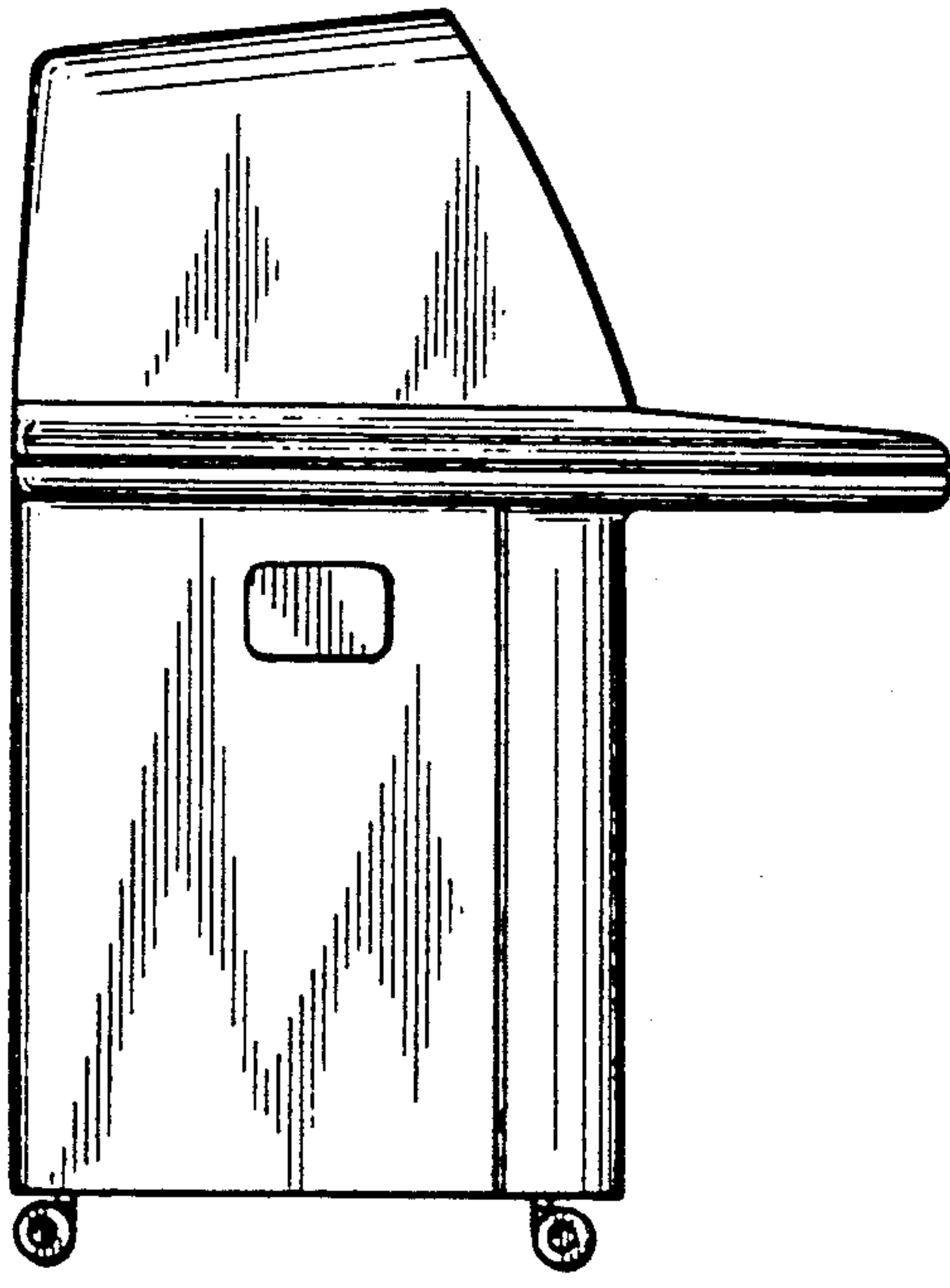


FIG. 5

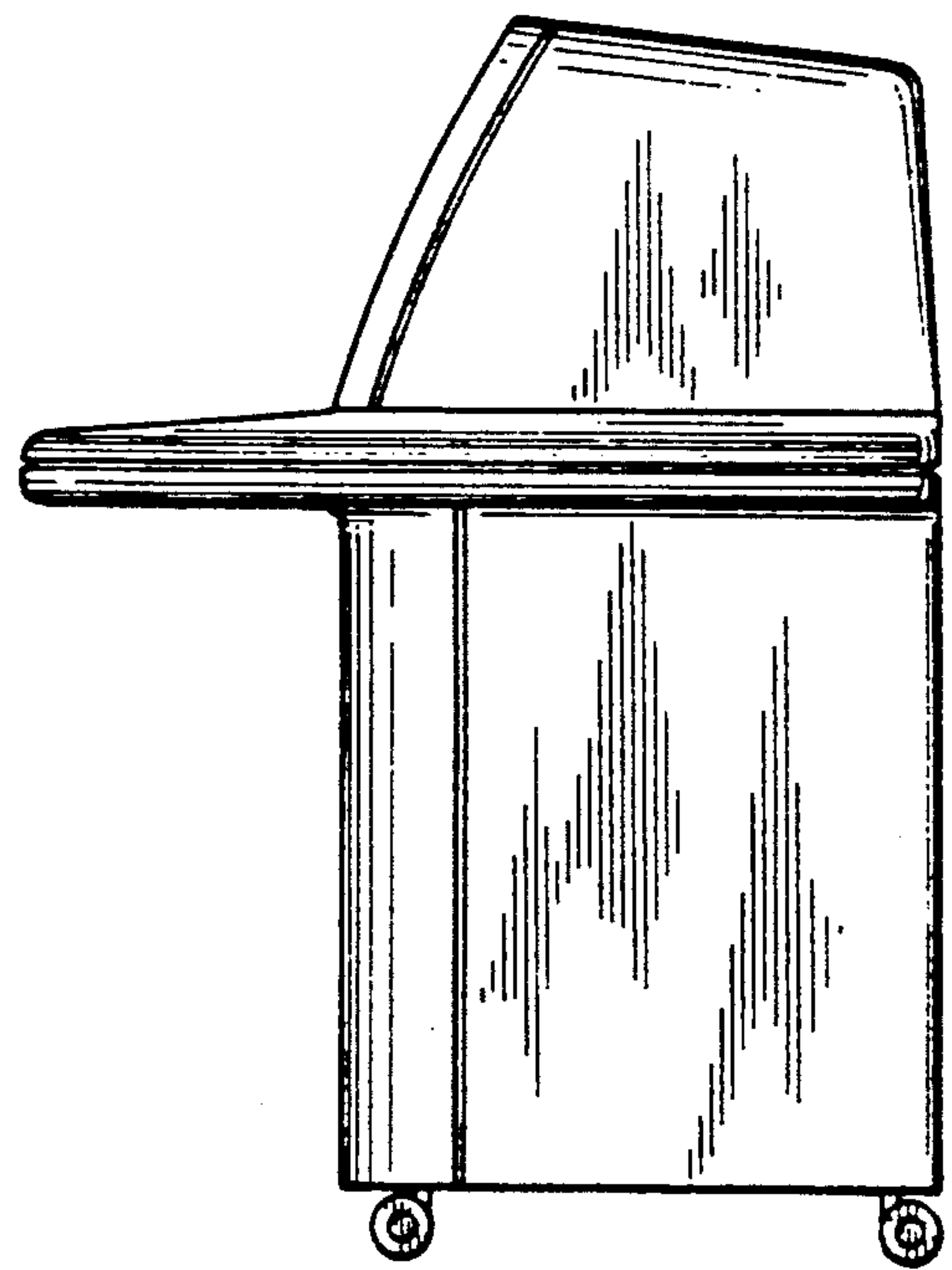


FIG. 6

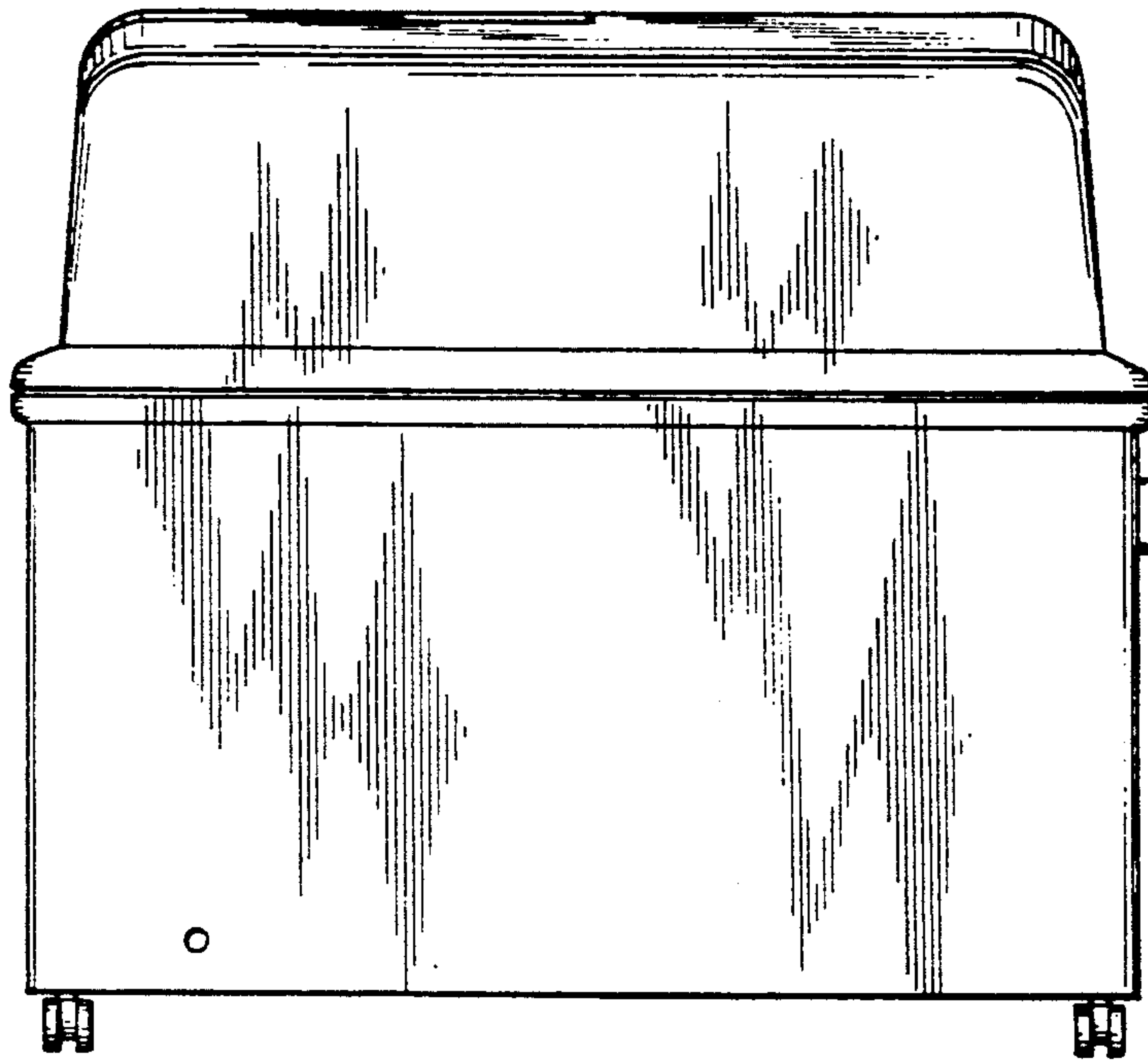


FIG. 7

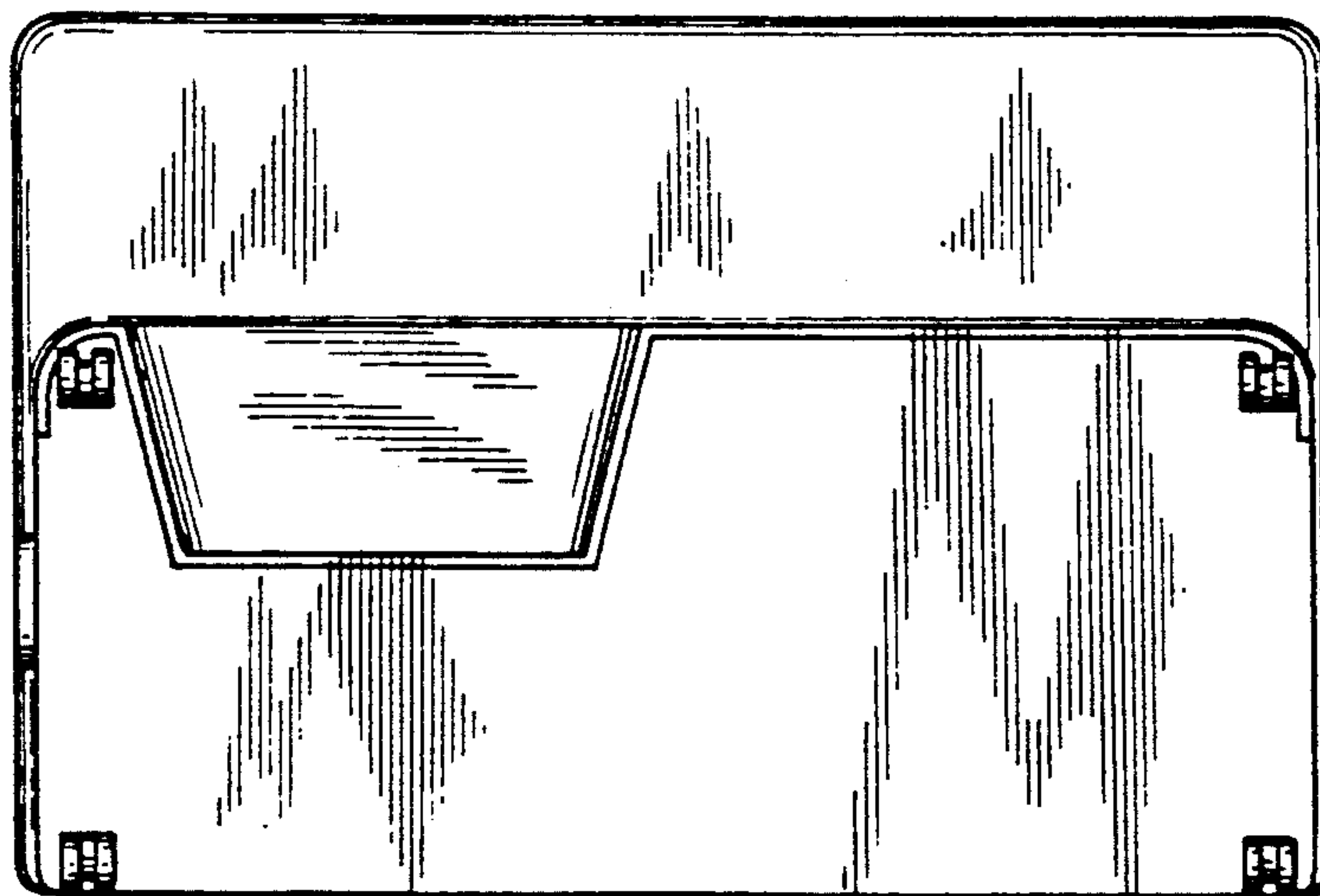


FIG. 8

